Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/015,180	JAIN ET AL.	
Examiner	Art Unit	
Thomas H. Stevens	2123	

Thomas H. Stevens

SEARCHED						
Class	Subclass	Date	Examiner			
	·					
703	19	12/16/05	TS			
713	500	1.	ı,			
713	502	31	l ₁			
			- "			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		<u> </u>			
US PG					
text search					
Dec. 10	,2005				

"See interference printout"

SEARCH NOTES				
(INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: Various Search Strategies (see notes)	12/1905	75		
Google Scholar: Inventors and Leywords from claims 1 +				
INSPEC + IEEE + Proquest Disserts his Inventors	ons:			